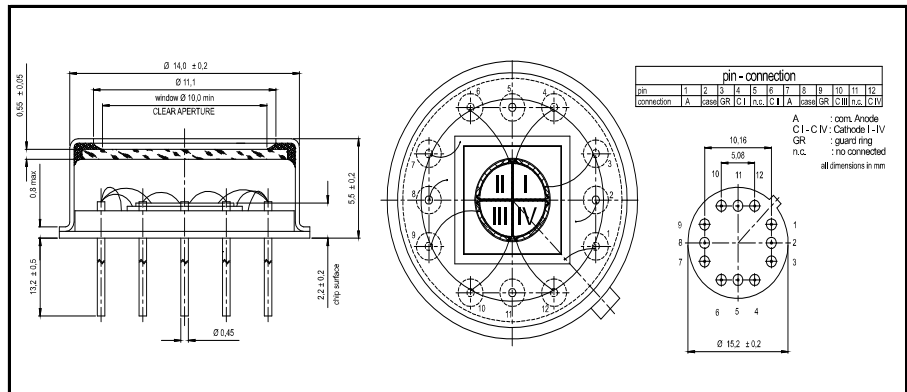
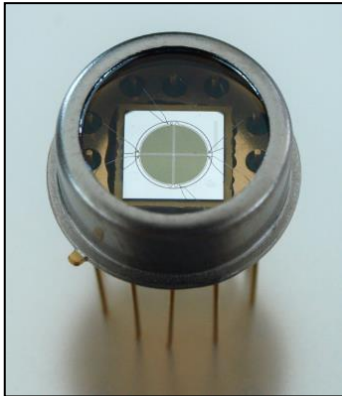




## Features

- Ø 4 mm total active area
- Segmented in 4 quadrants
- Slow multiplication curve
- QE > 80% @ 750 nm-910 nm
- Fast rise time, very low noise

## Description

Segmented quadrant avalanche photodiode with enhanced NIR responsivity in hermetic TO type metal can. Very low dark current due to guard ring diode.

## Application

- Pulsed 905nm laser detection
- Light source positioning
- Laser alignment

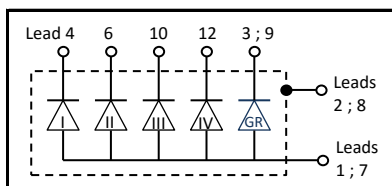
## RoHS

20011/65/EU

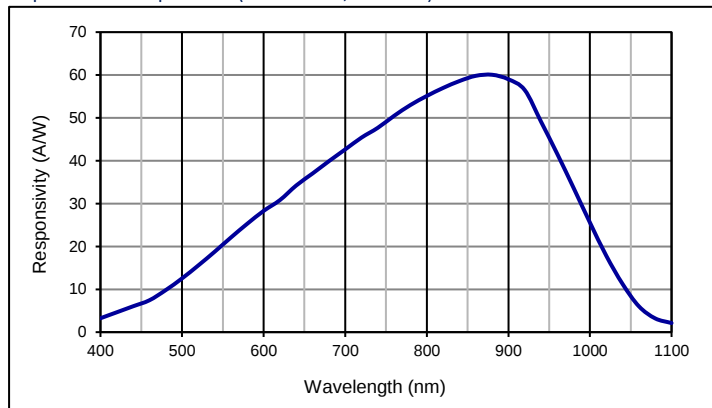
## Absolute maximum ratings

| Symbol     | Parameter               | Min | Max  | Unit |
|------------|-------------------------|-----|------|------|
| $T_{STG}$  | Storage temp            | -55 | 125  | °C   |
| $T_{OP}$   | Operating temp          | -40 | 100  | °C   |
| $M_{max}$  | Gain ( $I_{PD} = 1$ nA) | 200 |      |      |
| $I_{PEAK}$ | Peak DC current         |     | 0.25 | mA   |

## Schematic



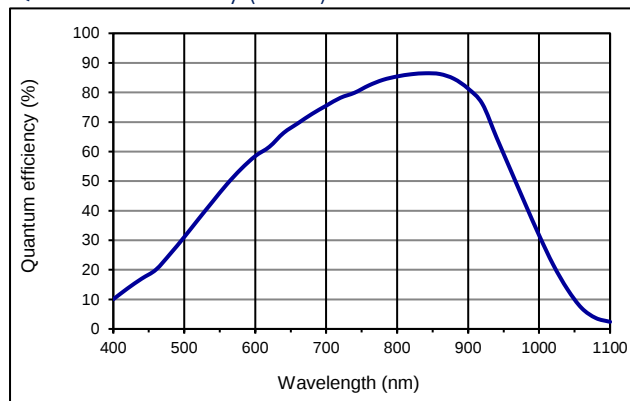
## Spectral response (M = 100; 23 °C)



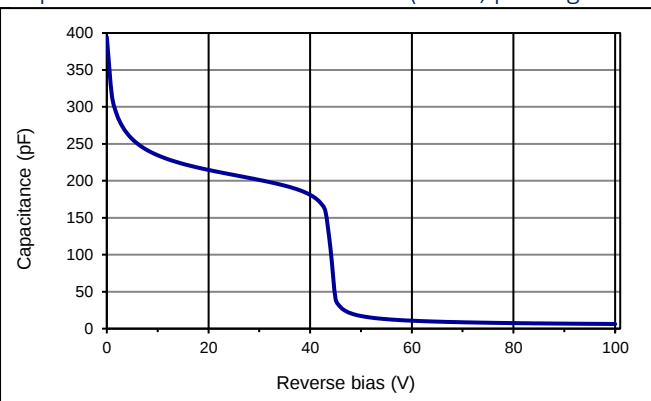
## Electro-optical characteristics @ 23 °C

| Symbol   | Characteristic           | Test Condition                                 | Min  | Typ    | Max  | Unit |
|----------|--------------------------|------------------------------------------------|------|--------|------|------|
|          | No of elements           |                                                |      | 4      |      |      |
|          | Active area              | segmented in 4 quadrants                       |      | Ø 4000 |      | µm   |
|          | Gap                      |                                                |      | 110    |      | µm   |
| $I_D$    | Dark current             | M = 100; $\lambda = 905$ nm, per segment       |      | 4      | 30   | nA   |
| C        | Capacitance              | M = 100, per segment                           |      | 7      |      | pF   |
|          | Responsivity             | M = 100; $\lambda = 905$ nm                    | 52   | 58     | 60   | A/W  |
| $t_R$    | Rise time                | M = 100; $\lambda = 905$ nm; $R_L = 50 \Omega$ |      | 2      |      | ns   |
| $V_{BR}$ | Breakdown voltage        | $I_R = 2 \mu A$                                | 160  |        | 240  | V    |
|          | Temperature coefficient  | Change of $V_{BR}$ with temperature            | 1.25 |        | 1.55 | V/K  |
|          | Excess noise factor      | M = 100                                        |      | 2.5    |      |      |
|          | Photo current uniformity | M = 100                                        |      | ± 5    |      | %    |
|          | Dark current uniformity  | M = 100                                        |      | ± 5    |      | %    |

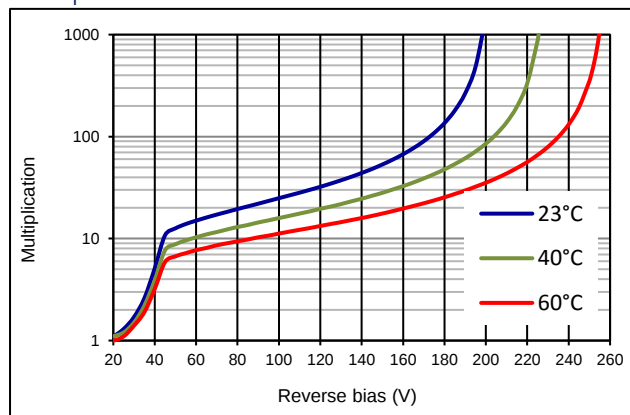
Quantum efficiency (23 °C)



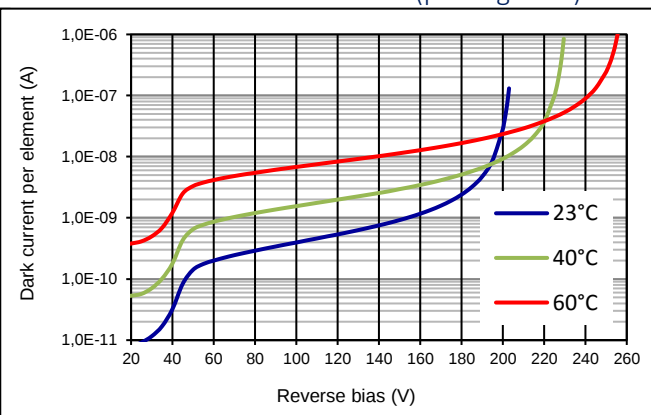
Capacitance as fct of reverse bias (23 °C, per segment)



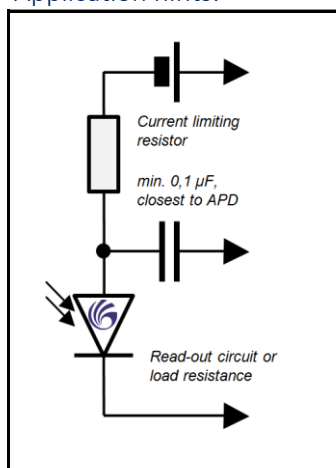
Multiplication as fct of reverse bias



Dark current as fct of reverse bias (per segment)

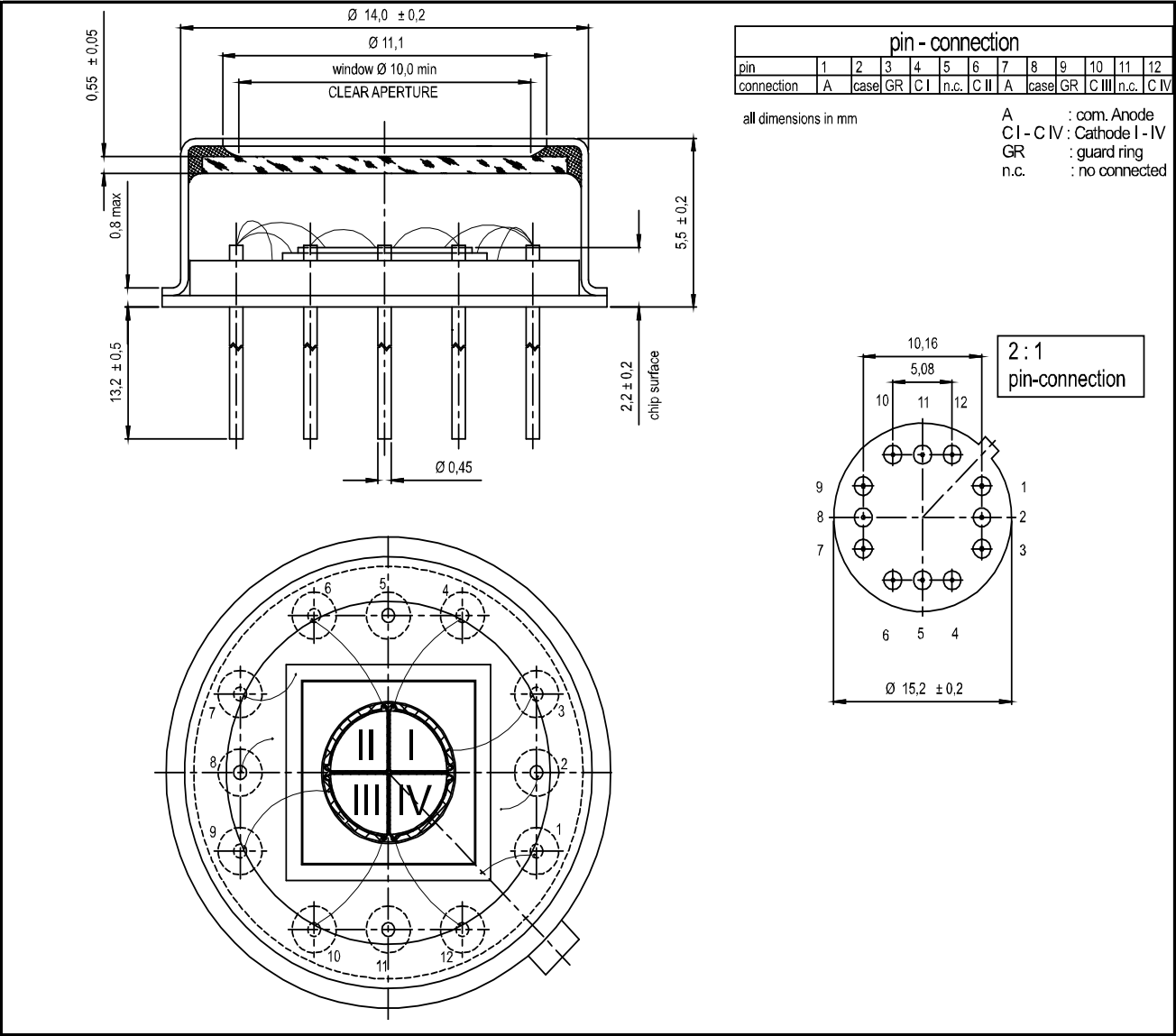


## Application hints:



- Current should be limited by a protecting resistor or current limiting - IC inside the power supply
- Guard ring should be connected to ground
- For low light level applications blocking of ambient light should be used
- For high gain applications bias voltage should be temperature compensated
- Please consider basic ESD protection while handling
- Use low noise read-out - IC
- For further questions please refer to document "Instructions for handling and processing" and application notes for APDs and APD-Arrays

Technical Drawing, Package: TO8Si



Package dimension

Small quantities: Chips on foam pad, boxed (12 cm x 16.5 cm)

Disclaimer: Due to our strive for continuous improvement, specifications are subject to change within our PCN policy according to JESD46C.

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